Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/752,073	SCHIER, JOHN E.	
Examiner	Art Unit	
Tri H. Phan	2661	

SEARCHED					
Class	Subclass	Date	Examiner		
375	88.13, 201.01, 201.02, 201.05	6/30/2004	TP		
370	493-495	6/30/2004	TP		
370	419	6/30/2004	TP		
375	222	3/23/2005	TP		
713	200-202	3/23/2005	TP		
Updated	search	10/28/2005	TP		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
-				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, IEEE, Internet search	6/30/2004	TP		
Consulted with Brian Nguyen (Pri)	3/23/2005	TP		
Consulted with Frank Duong (Pri)	10/28/2005	TP		